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U.S. PATENT & TRADEMARK OFFICE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Applicant:

Daniel Xu et al.

Serial No.: 09/976,641

Filed: October 12, 2001

For: Reducing Leakage Currents in
Memories With Phase-Change
Material

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§ Art Unit: 2815
§
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§ Examiner: B. Baumeister
§
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§ Atty Docket: ITO.0504US
§ P12497
§

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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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REPLY TO FINAL REJECTION

Sir:

In response to the final rejection mailed December 18, 2003, please amend the above-referenced patent application as follows:

Date of Deposit: December 30, 2003

I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated above and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Cynthia L. Hayden
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